













ESD

TVS

TSS

MOV

GDT

PLED

AON7422E-MS

Product specification





Description

The AON7422E-MS uses advanced trench technologyto provide excellent RDS(ON), low gate charge and operation with gate voltages as low as 4.5V. Thisdevice is suitable for use as a Battery protection or in other Switching application.

Features

VDS = 30V ID =80 A

 $RDS(ON) < 6 m\Omega$ @VGS=10V

Application

- Battery protection
- Load switch
- Uninterruptible power supply

Reference News

PACKAGE OUTLINE	N-Channel MOSFET	Marking
PIN1	G	MSKSEMI 7422E N30 ●
DFN3X3-8L		

Absolute Maximum Ratings (TC=25 °C unless otherwise specified)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	30	V
VGS	Gate-Source Voltage	±20	V
I⊳@Tc=25°C	Continuous Drain Current, V _{GS} @ 10V ¹	80	A
I⊳@Tc=100°C	Continuous Drain Current, V _{GS} @ 10V ¹	50	A
IDM	Pulsed Drain Current ²	162	A
EAS	Single Pulse Avalanche Energy ³	144.7	mJ
IAS	Avalanche Current	53.8	A
P₀@Tc=25°C	Total Power Dissipation ⁴	62.5	W
TSTG	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
ReJA	Thermal Resistance Junction-ambient ¹	62	°C/ W
ReJC	Thermal Resistance Junction-Case ¹	2.4	°C/ W



Electrical Characteristics (TJ=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			V
$^{\Delta}$ BV _{DSS} / $^{\Delta}$ T _J	BVDSS Temperature Coefficient	Reference to 25°C, I _D =1mA		0.0213		V/°C
Р		V _{GS} =10V , I _D =30A		4.7	6	0
R _{DS(ON)}	Static Drain-Source On-Resistance ²	In-Source On-Resistance ² V_{GS} =4.5V , I _D =15A		5.9	8	mΩ
V _{GS(th)}	Gate Threshold Voltage		1.0	1.5	2.5	V
${}^{\vartriangle}V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_{D}=250$ uA		-5.73		Mv/°C
1	Dursin Courses Lookana Current	V _{DS} =24V , V _{GS} =0V , T _J =25°C			1	
I _{DSS}	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =55°C			5	uA
I _{GSS}	Gate-Source Leakage Current	V_{GS} = ±20V , V_{DS} =0V			±100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =30A		26.5		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.4	2.8	Ω
Qg	Total Gate Charge (4.5V)			31.6		
Q _{gs}	Gate-Source Charge	V _{DS} =15V , V _{GS} =4.5V , I _D =15A		8.6		nC
Q_gd	Gate-Drain Charge			11.7		
T _{d(on)}	Turn-On Delay Time			9		
Tr	Rise Time	V _{DD} =15V , V _{GS} =10V , R _G =3.3		19		
$T_{d(off)}$	Turn-Off Delay Time	Ω I _D =15A		58		ns
T _f	Fall Time			15.2		
Ciss	Input Capacitance			3075	4000	
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		400	530	pF
C _{rss}	Reverse Transfer Capacitance			315		

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current ^{1,5}				80	А
Іѕм	Pulsed Source Current ^{2,5}	$V_G = V_D = 0V$, Force Current			162	А
Vsd	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25°C			1	V
t _{rr}	Reverse Recovery Time	IF=30A , dI/dt=100A/µs ,		18		nS
Qrr	Reverse Recovery Charge	TJ=25 °C		8		nC

Note :

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

2.The data tested by pulsed , pulse width $\leq -300 us$, duty cycle $\leq -2\%$

3. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V, L=0. 1mH, I_{AS}=53.8A

4. The power dissipation is limited by 1750 junction temperature

5. The data is theoretically the same as I_{D} and $I_{\text{DM}}\,$, in real applications , should be limited by total power dissipation.

AON7422E-MS



Typical Characteristics

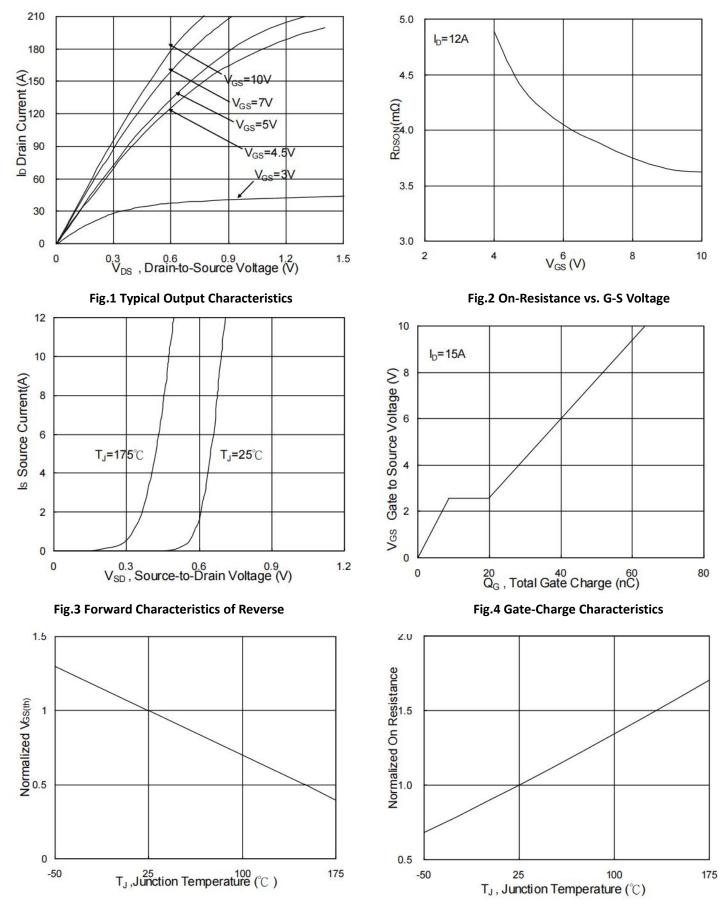


Fig.5 Normalized VGS(th) vs. TJ

Fig.6 Normalized RDSON vs. TJ



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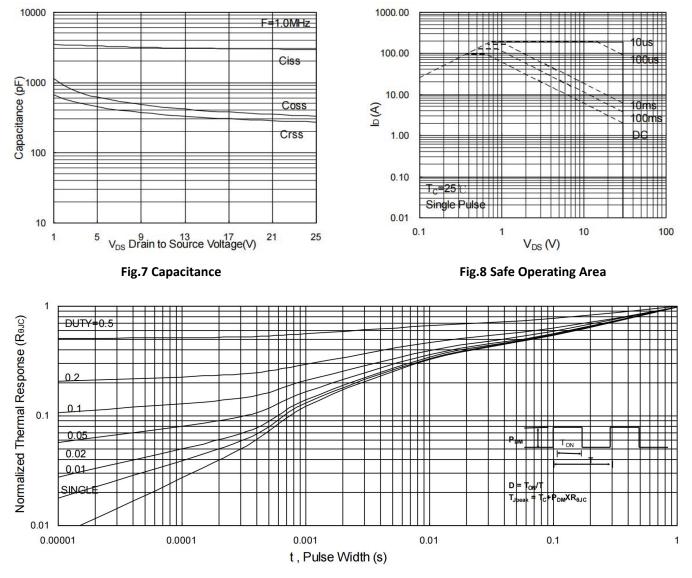


Fig.9 Normalized Maximum Transient Thermal Impedance

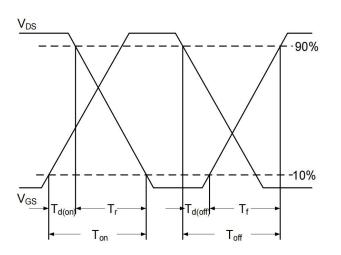


Fig.10 Switching Time Waveform

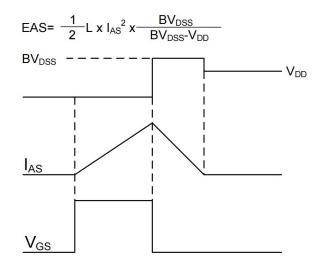
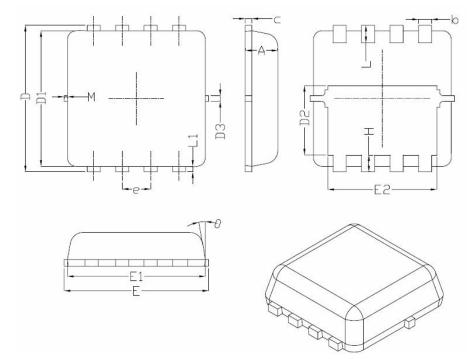


Fig.11 Unclamped Inductive Switching Waveform



DFN3X3-8L Package Information



Symbol	Dimensions In Millimeters			
	Min.	Nom.	Max.	
A	0.70	0.75	0.80	
b	0.25	0.30	0.35	
с	0.10	0.15	0.25	
D	3.25	3.35	3.45	
D1	3.00	3.10	3.20	
D2	1.48	1.58	1.68	
D3	-	0.13	-	
Е	3.20	3.30	3.40	
E1	3.00	3.15	3.20	
E2	2.39	2.49	2.59	
e	0.65BSC			
Н	0.30	0.39	0.50	
L	0.30	0.40	0.50	
L1	-	0.13	-	
М	*	*	0.15	
θ		10 [°]	12 [°]	

REEL SPECIFICATION

P/N	PKG	QTY
AON7422E-MS	DFN3X3-8L	5000



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